

# Rostislav Daniel

## List of Publications by Year in descending order

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82  
papers

2,545  
citations

172207

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223531

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82  
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82  
docs citations

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times ranked

1865  
citing authors

#	ARTICLE	IF	CITATIONS
1	The origin of stresses in magnetron-sputtered thin films with zone T structures. <i>Acta Materialia</i> , 2010, 58, 2621-2633.	3.8	152
2	Advanced characterization methods for wear resistant hard coatings: A review on recent progress. <i>Surface and Coatings Technology</i> , 2016, 285, 31-46.	2.2	116
3	X-ray nanodiffraction reveals strain and microstructure evolution in nanocrystalline thin films. <i>Scripta Materialia</i> , 2012, 67, 748-751.	2.6	103
4	Finite element simulation of the effect of surface roughness on nanoindentation of thin films with spherical indenters. <i>Surface and Coatings Technology</i> , 2007, 202, 1103-1107.	2.2	79
5	X-ray analysis of residual stress gradients in TiN coatings by a Laplace space approach and cross-sectional nanodiffraction: a critical comparison. <i>Journal of Applied Crystallography</i> , 2013, 46, 1378-1385.	1.9	78
6	Size effect of thermal expansion and thermal/intrinsic stresses in nanostructured thin films: Experiment and model. <i>Acta Materialia</i> , 2011, 59, 6631-6645.	3.8	77
7	Grain boundary design of thin films: Using tilted brittle interfaces for multiple crack deflection toughening. <i>Acta Materialia</i> , 2017, 122, 130-137.	3.8	71
8	Structure and thermal stability of arc evaporated $(\text{Ti}_{0.33}\text{Al}_{0.67})_{1-x}\text{Si}_x\text{N}$ thin films. <i>Thin Solid Films</i> , 2008, 517, 714-721.	0.8	68
9	A novel approach for determining fracture toughness of hard coatings on the micrometer scale. <i>Scripta Materialia</i> , 2012, 67, 708-711.	2.6	61
10	Fracture toughness enhancement of brittle nanostructured materials by spatial heterogeneity: A micromechanical proof for CrN/Cr and TiN/SiO <sub>x</sub> multilayers. <i>Materials and Design</i> , 2016, 104, 227-234.	3.3	60
11	Origins of microstructure and stress gradients in nanocrystalline thin films: The role of growth parameters and self-organization. <i>Acta Materialia</i> , 2013, 61, 6255-6266.	3.8	59
12	Structure and mechanical properties of magnetron sputtered Zr <sub>1-x</sub> Ti <sub>x</sub> Cu <sub>1-y</sub> N films. <i>Surface and Coatings Technology</i> , 2003, 166, 243-253.	2.2	58
13	Structure and properties of magnetron sputtered Zr <sub>1-x</sub> Si <sub>x</sub> N films with a high (â‰¥25 at.%) Si content. <i>Thin Solid Films</i> , 2005, 478, 238-247.	0.8	57
14	Nanoscale residual stress depth profiling by Focused Ion Beam milling and eigenstrain analysis. <i>Materials and Design</i> , 2018, 145, 55-64.	3.3	54
15	X-ray nanodiffraction reveals stress distribution across an indented multilayered CrN <sub>1-x</sub> Cr thin film. <i>Acta Materialia</i> , 2015, 85, 24-31.	3.8	53
16	In-situ Observation of Cross-Sectional Microstructural Changes and Stress Distributions in Fracturing TiN Thin Film during Nanoindentation. <i>Scientific Reports</i> , 2016, 6, 22670.	1.6	52
17	30 nm X-ray focusing correlates oscillatory stress, texture and structural defect gradients across multilayered TiN-SiO <sub>x</sub> thin film. <i>Acta Materialia</i> , 2018, 144, 862-873.	3.8	51
18	Properties of reactively sputtered W <sub>1-x</sub> Si <sub>x</sub> N films. <i>Surface and Coatings Technology</i> , 2006, 200, 3886-3895.	2.2	50

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19	Influence of Al and Si content on structure and mechanical properties of arc evaporated Al <sub>1-x</sub> Cr <sub>x</sub> Si <sub>1-x</sub> N thin films. <i>Thin Solid Films</i> , 2013, 534, 403-409.	0.8	48
20	Self-organized periodic soft-hard nanolamellae in polycrystalline TiAlN thin films. <i>Thin Solid Films</i> , 2013, 545, 29-32.	0.8	46
21	Superior oxidation resistance, mechanical properties and residual stresses of an Al-rich nanolamellar Ti <sub>0.05</sub> Al <sub>0.95</sub> N coating prepared by CVD. <i>Surface and Coatings Technology</i> , 2014, 258, 1119-1127.	2.2	44
22	High-temperature oxidation resistance of Ta <sub>1-x</sub> Si <sub>x</sub> N films with a high Si content. <i>Surface and Coatings Technology</i> , 2006, 200, 4091-4096.	2.2	42
23	Al-rich cubic Al <sub>0.8</sub> Ti <sub>0.2</sub> N coating with self-organized nano-lamellar microstructure: Thermal and mechanical properties. <i>Surface and Coatings Technology</i> , 2016, 291, 89-93.	2.2	42
24	Thermal stability of magnetron sputtered Zr <sub>1-x</sub> Si <sub>x</sub> N films. <i>Surface and Coatings Technology</i> , 2006, 201, 3368-3376.	2.2	40
25	Texture development in polycrystalline CrN coatings: the role of growth conditions and a Cr interlayer. <i>Journal Physics D: Applied Physics</i> , 2009, 42, 075401.	1.3	40
26	Lateral gradients of phases, residual stress and hardness in a laser heated Ti <sub>0.52</sub> Al <sub>0.48</sub> N coating on hard metal. <i>Surface and Coatings Technology</i> , 2012, 206, 4502-4510.	2.2	37
27	Evolution of structure and residual stress of a fcc/hex-AlCrN multi-layered system upon thermal loading revealed by cross-sectional X-ray nano-diffraction. <i>Acta Materialia</i> , 2019, 162, 55-66.	3.8	35
28	Cross-sectional structure-property relationship in a graded nanocrystalline Ti <sub>1-x</sub> Al <sub>x</sub> N thin film. <i>Acta Materialia</i> , 2016, 102, 212-219.	3.8	34
29	Microstructural evolution and thermal stability of AlCr(Si)N hard coatings revealed by in-situ high-temperature high-energy grazing incidence transmission X-ray diffraction. <i>Acta Materialia</i> , 2020, 186, 545-554.	3.8	34
30	Stress evolution in CrN/Cr coating systems during thermal straining. <i>Thin Solid Films</i> , 2008, 516, 1972-1976.	0.8	30
31	Interlayer thickness influence on the tribological response of bi-layer coatings. <i>Tribology International</i> , 2010, 43, 108-112.	3.0	29
32	Cross-sectional X-ray nanobeam diffraction analysis of a compositionally graded CrN <sub>x</sub> thin film. <i>Thin Solid Films</i> , 2013, 542, 1-4.	0.8	29
33	Using pulsed and modulated photothermal radiometry to measure the thermal conductivity of thin films. <i>Thermochimica Acta</i> , 2013, 556, 1-5.	1.2	28
34	Peculiarity of self-assembled cubic nanolamellae in the TiN/AlN system: Epitaxial self-stabilization by element deficiency/excess. <i>Acta Materialia</i> , 2017, 131, 391-399.	3.8	28
35	Residual stresses and thermal fatigue in CrN hard coatings characterized by high-temperature synchrotron X-ray diffraction. <i>Thin Solid Films</i> , 2010, 518, 2090-2096.	0.8	27
36	X-ray diffraction analysis of three-dimensional residual stress fields reveals origins of thermal fatigue in uncoated and coated steel. <i>Scripta Materialia</i> , 2010, 62, 774-777.	2.6	26

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37	Structural characterization of a Cu/MgO(001) interface using CS-corrected HRTEM. <i>Thin Solid Films</i> , 2010, 519, 1662-1667.	0.8	26
38	Anisotropy of fracture toughness in nanostructured ceramics controlled by grain boundary design. <i>Materials and Design</i> , 2019, 161, 80-85.	3.3	26
39	Elastic constants of fibre-textured thin films determined by X-ray diffraction. <i>Journal of Applied Crystallography</i> , 2009, 42, 416-428.	1.9	25
40	Complementary ab initio and X-ray nanodiffraction studies of Ta <sub>2</sub> O <sub>5</sub> . <i>Acta Materialia</i> , 2015, 83, 276-284.	3.8	24
41	Microstructure and mechanical properties of nanocrystalline Al-Cr-B-N thin films. <i>Surface and Coatings Technology</i> , 2012, 213, 1-7.	2.2	23
42	Insights into the atomic and electronic structure triggered by ordered nitrogen vacancies in CrN. <i>Physical Review B</i> , 2013, 87, .	1.1	22
43	The peculiarity of the metal-ceramic interface. <i>Scientific Reports</i> , 2015, 5, 11460.	1.6	22
44	Residual stresses in thermally cycled CrN coatings on steel. <i>Thin Solid Films</i> , 2008, 517, 1167-1171.	0.8	19
45	Combinatorial refinement of thin-film microstructure, properties and process conditions: iterative nanoscale search for self-assembled TiAlN nanolamellae. <i>Journal of Applied Crystallography</i> , 2016, 49, 2217-2225.	1.9	19
46	Biomimetic hard and tough nanoceramic Ti-Al-N film with self-assembled six-level hierarchy. <i>Nanoscale</i> , 2019, 11, 7986-7995.	2.8	19
47	Thermally-induced formation of hexagonal AlN in AlCrN hard coatings on sapphire: Orientation relationships and residual stresses. <i>Surface and Coatings Technology</i> , 2010, 205, 1320-1323.	2.2	18
48	Influence of varying nitrogen partial pressures on microstructure, mechanical and optical properties of sputtered TiAlON coatings. <i>Acta Materialia</i> , 2016, 119, 26-34.	3.8	18
49	Nanoscale evolution of stress concentrations and crack morphology in multilayered CrN coating during indentation: Experiment and simulation. <i>Materials and Design</i> , 2020, 188, 108478.	3.3	18
50	A combinatorial X-ray sub-micron diffraction study of microstructure, residual stress and phase stability in TiAlN coatings. <i>Surface and Coatings Technology</i> , 2014, 257, 108-113.	2.2	17
51	Mechanical and tribological properties of AlTiN/AlCrBN multilayer films synthesized by cathodic arc evaporation. <i>Surface and Coatings Technology</i> , 2014, 246, 57-63.	2.2	17
52	Nanoscale residual stress and microstructure gradients across the cutting edge area of a TiN coating on WC Co. <i>Scripta Materialia</i> , 2020, 182, 11-15.	2.6	17
53	Rapid determination of stress factors and absolute residual stresses in thin films. <i>Journal of Applied Crystallography</i> , 2006, 39, 777-783.	1.9	16
54	Oxidation behavior of arc evaporated Al-Cr-Si-N thin films. <i>Journal of Vacuum Science and Technology A: Vacuum, Surfaces and Films</i> , 2012, 30, .	0.9	16

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55	Multi-scale interface design of strong and damage resistant hierarchical nanostructured materials. <i>Materials and Design</i> , 2020, 196, 109169.	3.3	16
56	Microstructure modifications of CrN coatings by pulsed bias sputtering. <i>Surface and Coatings Technology</i> , 2012, 206, 4666-4671.	2.2	15
57	Mechanical property enhancement in laminates through control of morphology and crystal orientation. <i>Journal Physics D: Applied Physics</i> , 2015, 48, 295303.	1.3	15
58	Resolving depth evolution of microstructure and hardness in sputtered CrN film. <i>Thin Solid Films</i> , 2015, 581, 75-79.	0.8	15
59	Antibacterial Silicon Oxide Thin Films Doped with Zinc and Copper Grown by Atmospheric Pressure Plasma Chemical Vapor Deposition. <i>Nanomaterials</i> , 2019, 9, 255.	1.9	15
60	X-ray nanodiffraction analysis of stress oscillations in a W thin film on through-silicon via. <i>Journal of Applied Crystallography</i> , 2016, 49, 182-187.	1.9	14
61	Microstructure-controlled depth gradients of mechanical properties in thin nanocrystalline films: Towards structure-property gradient functionalization. <i>Journal of Applied Physics</i> , 2015, 117, .	1.1	13
62	Mono-textured nanocrystalline thin films with pronounced stress-gradients: On the role of grain boundaries in the stress evolution. <i>Journal of Applied Physics</i> , 2014, 115, .	1.1	12
63	Stress-controlled decomposition routes in cubic AlCrN films assessed by in-situ high-temperature high-energy grazing incidence transmission X-ray diffraction. <i>Scientific Reports</i> , 2019, 9, 18027.	1.6	12
64	Structure-stress relationships in nanocrystalline multilayered Al <sub>0.7</sub> Cr <sub>0.3</sub> N/Al <sub>0.9</sub> Cr <sub>0.1</sub> N coatings studied by cross-sectional X-ray nanodiffraction. <i>Materials and Design</i> , 2019, 170, 107702.	3.3	11
65	Impact of Si on the high-temperature oxidation of AlCr(Si)N coatings. <i>Journal of Materials Science and Technology</i> , 2022, 100, 91-100.	5.6	11
66	High-temperature residual stresses in thin films characterized by x-ray diffraction substrate curvature method. <i>Review of Scientific Instruments</i> , 2007, 78, 036103.	0.6	10
67	Microstructure, mechanical and optical properties of TiAlON coatings sputter-deposited with varying oxygen partial pressures. <i>Journal Physics D: Applied Physics</i> , 2016, 49, 025307.	1.3	10
68	Hierarchical Architectures to Enhance Structural and Functional Properties of Brittle Materials. <i>Advanced Engineering Materials</i> , 2017, 19, 1600683.	1.6	10
69	Evolution of stress fields during crack growth and arrest in a brittle-ductile CrN-Cr clamped-cantilever analysed by X-ray nanodiffraction and modelling. <i>Materials and Design</i> , 2021, 198, 109365.	3.3	10
70	Precipitation-based grain boundary design alters Inter- to Trans-granular Fracture in AlCrN Thin Films. <i>Acta Materialia</i> , 2022, 237, 118156.	3.8	10
71	Influence of the Silver Content on Mechanical Properties of Ti-Cu-Ag Thin Films. <i>Nanomaterials</i> , 2021, 11, 435.	1.9	8
72	Nitrogen atom shift and the structural change in chromium nitride. <i>Acta Materialia</i> , 2015, 98, 119-127.	3.8	6

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73	Atomic and electronic structures of a transition layer at the CrN/Cr interface. Journal of Applied Physics, 2011, 110, 043524.	1.1	5
74	Complementary High Spatial Resolution Methods in Materials Science and Engineering. Advanced Engineering Materials, 2017, 19, 1600671.	1.6	5
75	Extraordinary high-temperature behavior of electrically conductive Hf <sub>7</sub> B <sub>23</sub> Si <sub>22</sub> C <sub>6</sub> N <sub>40</sub> ceramic film. Surface and Coatings Technology, 2020, 391, 125686.	2.2	5
76	Evolution of structure, residual stress, thermal stability and wear resistance of nanocrystalline multilayered Al <sub>0.7</sub> Cr <sub>0.3</sub> N-Al <sub>0.67</sub> Ti <sub>0.33</sub> N coatings. Surface and Coatings Technology, 2021, 425, 127712.	2.2	5
77	Nanoscale stress distributions and microstructural changes at scratch track cross-sections of a deformed brittle-ductile CrN-Cr bilayer. Materials and Design, 2020, 195, 109023.	3.3	4
78	Transmission electron microscopy characterization of CrN films on MgO(001). Thin Solid Films, 2013, 545, 154-160.	0.8	3
79	Ion irradiation-induced localized stress relaxation in W thin film revealed by cross-sectional X-ray nanodiffraction. Thin Solid Films, 2021, 722, 138571.	0.8	3
80	Stress in physical vapor deposited thin films: Measurement methods and selected examples. , 2021, , 359-436.		2
81	A Novel Technique to Determine Elastic Constants of Thin Films. Materials Research Society Symposia Proceedings, 2008, 1139, 1.	0.1	0
82	Macroscopic Fracture Behaviour of CrN Hard Coatings Evaluated by X-Ray Diffraction Coupled with Four-Point Bending. Materials Science Forum, 2013, 768-769, 272-279.	0.3	0